

# **Maximum Ratings** (@ $T_A = +25$ °C, unless otherwise specified.)

| Characteristic  | Symbol          | Value  | Unit             |          |    |
|---|-----------------|--|------------------|----------|----|
| Drain-Source Voltage                                    |                 |  | V <sub>DSS</sub> | 60       | V  |
| Gate-Source Voltage                                     |                 |  | Vgss             | ±20      | V  |
| Continuous Drain Current (Note 6) Voc = 10V             |                 | $T_C = +25$ °C<br>$T_C = +70$ °C             | lo               | 32<br>25 | А  |
| Continuous Drain Current (Note 5) V <sub>GS</sub> = 10V | Steady<br>State | $T_A = +25^{\circ}C$<br>$T_A = +70^{\circ}C$ | lo               | 10<br>8  | А  |
| Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)      |                 |  | I <sub>DM</sub>  | 120      | Α  |
| Maximum Continuous Body Diode Forward Current (Note 6)  |                 |  | Is               | 27       | Α  |
| Avalanche Current (Note 7) L = 0.1mH                    |                 |  | I <sub>AS</sub>  | 15.3     | Α  |
| Avalanche Energy (Note 7) L = 0.1mH                     |                 |  | Eas              | 11.7     | mJ |

### **Thermal Characteristics**

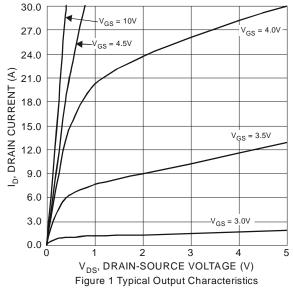
| Characteristic                                   |                        | Symbol            | Value       | Unit |
|--|------------------------|-------------------|-------------|------|
| Total Power Dissipation (Note 5)                 | T <sub>A</sub> = +25°C | PD                | 2.6         | W    |
| Thermal Resistance, Junction to Ambient (Note 5) | Steady State           | $R_{\theta JA}$   | 49          | °C/W |
| Total Power Dissipation (Note 6)                 | $T_C = +25^{\circ}C$   | P <sub>D</sub>    | 26          | W    |
| Thermal Resistance, Junction to Case (Note 6)    |                        | R <sub>θ</sub> JC | 4.8         | °C/W |
| Operating and Storage Temperature Range          |                        | TJ, TSTG          | -55 to +150 | °C   |

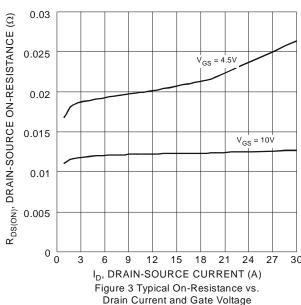
### Electrical Characteristics (@TA = +25°C, unless otherwise specified.)

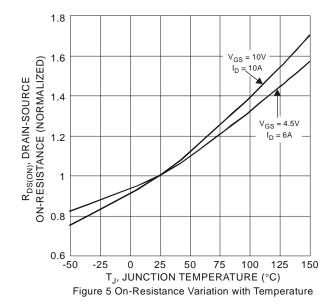
| Characteristic                             | Symbol           | Min | Тур | Max  | Unit | Test Condition  |  |
|--|------------------|-----|-----|------|------|---|--|
| OFF CHARACTERISTICS (Note 8)               |                  |     |     |      |      |   |  |
| Drain-Source Breakdown Voltage             | BVDSS            | 60  | _   | _    | V    | $V_{GS} = 0V, I_{D} = 250\mu A$                                 |  |
| Zero Gate Voltage Drain Current            | I <sub>DSS</sub> | _   | _   | 1    | μΑ   | V <sub>DS</sub> =48V, V <sub>GS</sub> = 0V                      |  |
| Gate-Source Leakage                        | Igss             | _   | _   | ±100 | nA   | $V_{GS} = \pm 20V, V_{DS} = 0V$                                 |  |
| ON CHARACTERISTICS (Note 8)                |                  |     |     |      |      |   |  |
| Gate Threshold Voltage                     | Vgs(TH)          | 1   | _   | 2.5  | V    | $V_{DS} = V_{GS}$ , $I_D = 250\mu A$                            |  |
| Static Drain-Source On-Resistance          | -                |     | 1   | 15   | mΩ   | Vgs = 10V, ID = 20A   |  |
|  | Rds(on)          |     |     | 24   |      | $V_{GS} = 4.5V, I_D = 18A$                                      |  |
| Diode Forward Voltage                      | VsD              |     | 0.7 | 1.2  | ٧    | Vgs = 0V, Is = 1A   |  |
| DYNAMIC CHARACTERISTICS (Note 9)           |                  |     |     |      |      |   |  |
| Input Capacitance                          | Ciss             | _   | 864 | _    |      | V <sub>DS</sub> = 30V, V <sub>GS</sub> = 0V,<br>f = 1MHz        |  |
| Output Capacitance                         | Coss             | _   | 282 | _    | pF   |   |  |
| Reverse Transfer Capacitance               | Crss             | _   | 27  | _    |      |   |  |
| Gate Resistance                            | Rg               | _   | 1.3 | _    | Ω    | $V_{DS} = 0V$ , $V_{GS} = 0V$ , $f = 1MHz$                      |  |
| Total Gate Charge (V <sub>GS</sub> = 4.5V) | Qg               | _   | 8.4 | _    |      | V <sub>DS</sub> = 30V, I <sub>D</sub> = 10A                     |  |
| Total Gate Charge (V <sub>GS</sub> = 10V)  | Qg               | _   | 17  | _    | nC   |   |  |
| Gate-Source Charge                         | Qgs              | _   | 3.1 | _    | nc   |   |  |
| Gate-Drain Charge                          | $Q_{gd}$         | _   | 4.3 | _    |      |   |  |
| Turn-On Delay Time                         | td(ON)           | _   | 3.4 | _    |      | $V_{GS} = 10V, V_{DS} = 30V,$<br>$R_{G} = 6\Omega, I_{D} = 10A$ |  |
| Turn-On Rise Time                          | t <sub>R</sub>   | _   | 5.2 | _    |      |   |  |
| Turn-Off Delay Time                        | tD(OFF)          | _   | 13  | _    | ns   |   |  |
| Turn-Off Fall Time                         | tF               | _   | 7   | _    |      |   |  |
| Reverse Recovery Time                      | t <sub>RR</sub>  | _   | 22  | _    | ns   | I- 400 di/dt 4000/  |  |
| Reverse Recovery Charge                    | Qrr              | _   | 11  | _    | nC   | $I_F = 10A$ , di/dt = 100A/ $\mu$ s                             |  |

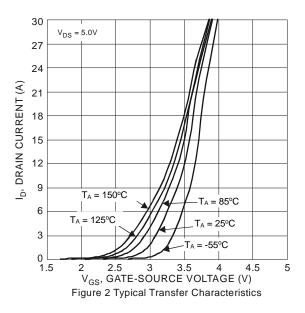
 Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate.
Thermal resistance from junction to soldering point (on the exposed drain pad).
I<sub>AS</sub> and E<sub>AS</sub> rating are based on low frequency and duty cycles to keep T<sub>J</sub> = +25°C.
Short duration pulse test used to minimize self-heating effect.
Guaranteed by design. Not subject to product testing. Notes:

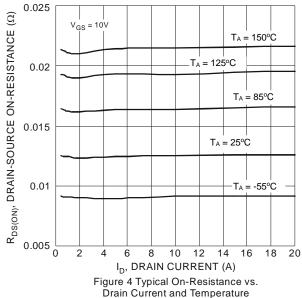












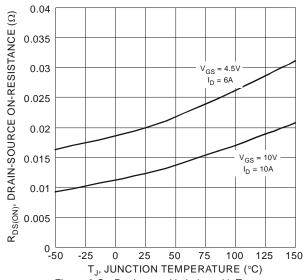


Figure 6 On-Resistance Variation with Temperature



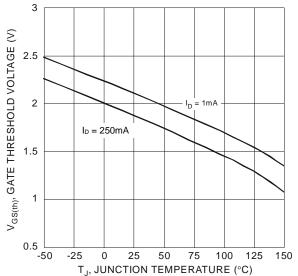


Figure 7 Gate Threshold Variation vs. Junction Temperature

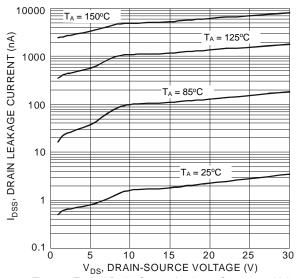
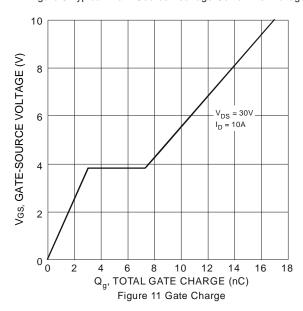
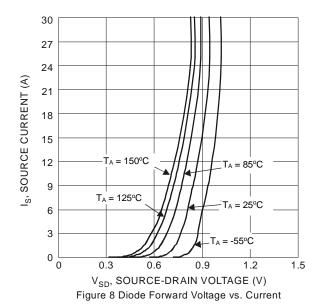
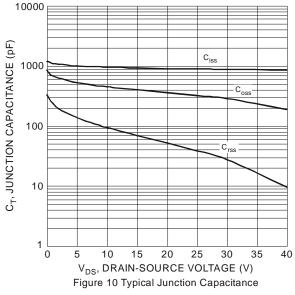
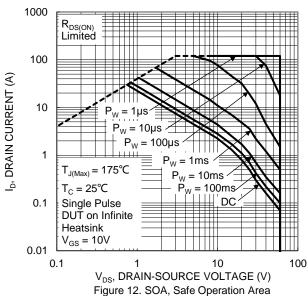


Figure 9 Typical Drain-Source Leakage Current vs. Voltage











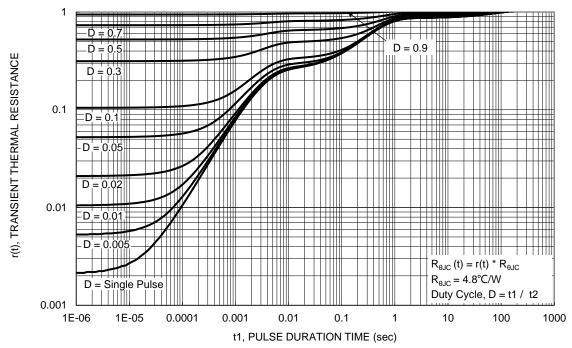


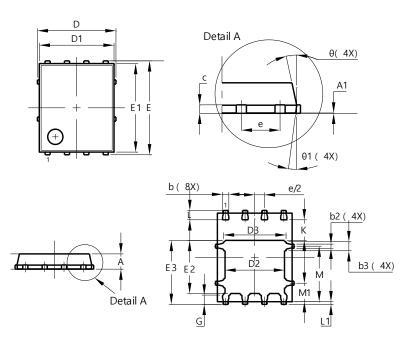
Figure 13. Transient Thermal Resistance



## **Package Outline Dimensions**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### PowerDI5060-8

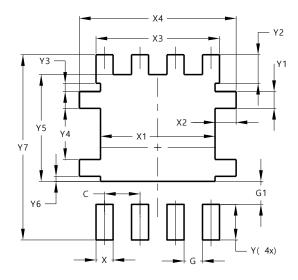


| PowerDI5060-8        |          |       |       |  |  |  |
|----------------------|----------|-------|-------|--|--|--|
| Dim                  | Min      | Max   | Тур   |  |  |  |
| Α                    | 0.90     | 1.10  | 1.00  |  |  |  |
| <b>A</b> 1           | 0.00     | 0.05  |       |  |  |  |
| b                    | 0.33     | 0.51  | 0.41  |  |  |  |
| b2                   | 0.200    | 0.350 | 0.273 |  |  |  |
| b3                   | 0.40     | 0.80  | 0.60  |  |  |  |
| С                    | 0.230    | 0.330 | 0.277 |  |  |  |
| D                    | 5.15 BSC |       |       |  |  |  |
| D1                   | 4.70     | 5.10  | 4.90  |  |  |  |
| D2                   | 3.70     | 4.10  | 3.90  |  |  |  |
| D3                   | 3.90     | 4.30  | 4.10  |  |  |  |
| Е                    | 6.15 BSC |       |       |  |  |  |
| E1                   | 5.60     | 6.00  | 5.80  |  |  |  |
| E2                   | 3.28     | 3.68  | 3.48  |  |  |  |
| E3                   | 3.99     | 4.39  | 4.19  |  |  |  |
| е                    | 1.27 BSC |       |       |  |  |  |
| G                    | 0.51     | 0.71  | 0.61  |  |  |  |
| K                    | 0.51     |       |       |  |  |  |
| L                    | 0.51     | 0.71  | 0.61  |  |  |  |
| L1                   | 0.100    | 0.200 | 0.175 |  |  |  |
| М                    | 3.235    | 4.035 | 3.635 |  |  |  |
| M1                   | 1.00     | 1.40  | 1.21  |  |  |  |
| Θ                    | 10°      | 12°   | 11°   |  |  |  |
| Θ1                   | 6°       | 8°    | 7°    |  |  |  |
| All Dimensions in mm |          |       |       |  |  |  |

# **Suggested Pad Layout**

Please see http://www.diodes.com/package-outlines.html for the latest version.

### PowerDI5060-8



| Dimensions | Value (in mm) |  |  |  |
|------------|---------------|--|--|--|
| С          | 1.270         |  |  |  |
| G          | 0.660         |  |  |  |
| G1         | 0.820         |  |  |  |
| X          | 0.610         |  |  |  |
| X1         | 4.100         |  |  |  |
| X2         | 0.755         |  |  |  |
| Х3         | 4.420         |  |  |  |
| X4         | 5.610         |  |  |  |
| Υ          | 1.270         |  |  |  |
| Y1         | 0.600         |  |  |  |
| Y2         | 1.020         |  |  |  |
| Y3         | 0.295         |  |  |  |
| Y4         | 1.825         |  |  |  |
| Y5         | 3.810         |  |  |  |
| Y6         | 0.180         |  |  |  |
| Y7         | 6.610         |  |  |  |



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